

<b>Notice of References Cited</b>	Application/Control No. 10/665,591	Applicant(s)/Patent Under Reexamination YAMANOUCHI ET AL.	
	Examiner Christopher RoDee	Art Unit 1756	Page 1 of 1

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	C	US-2003/0027072	02-2003	Horiuchi et al.	430/110.1
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